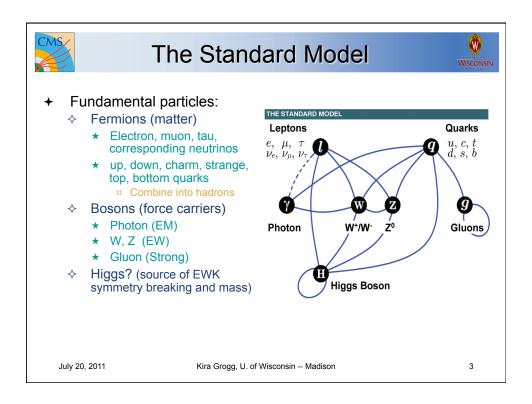
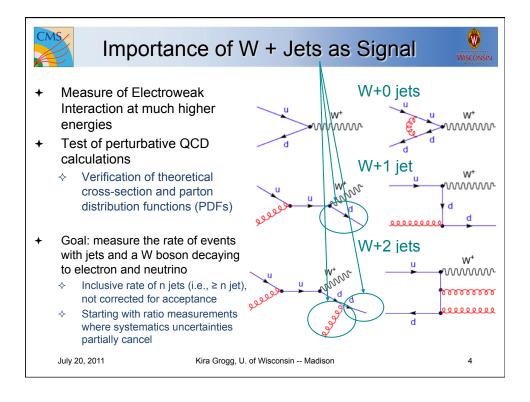
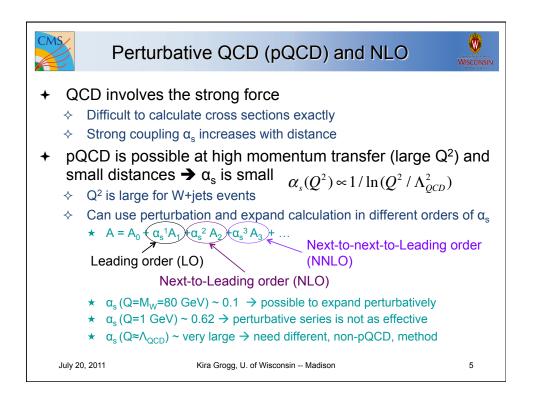
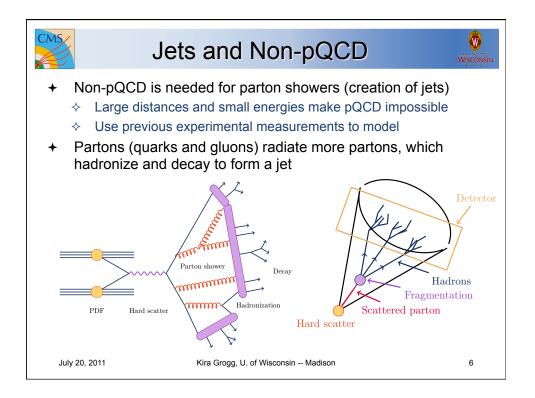


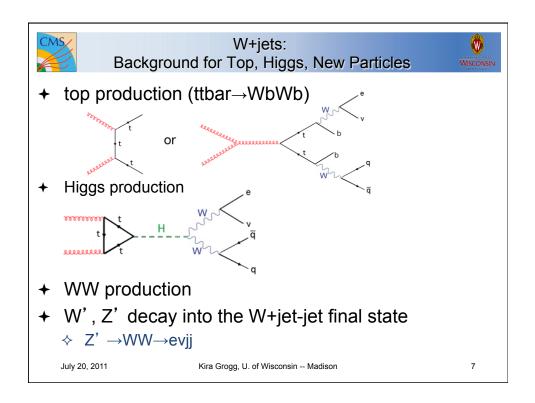
Outl	
 Introduction Standard Model Importance of W+jets Experiment Large Hadron Collider Compact Muon Solenoid Tracker Calorimeters Trigger Monte Carlo Simulation 	 + Reconstruction ◇ Electrons, E_T^{miss}, jets + W+jets analysis ◇ Samples ◇ Selection ◇ Efficiency ◇ Data-MC comparisons ◇ Signal Extraction ◇ Unfolding + Results + Summary/Outlook
July 20, 2011 Kira Grogg, U. of W	Visconsin Madison 2

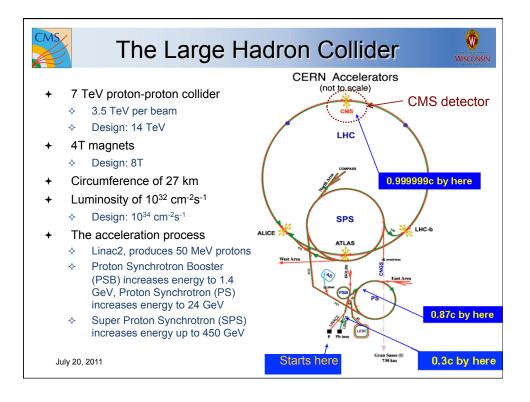


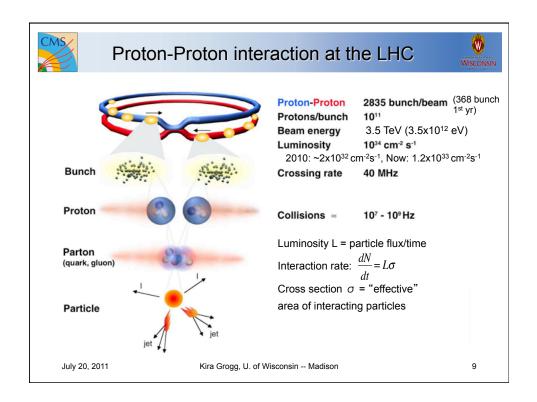


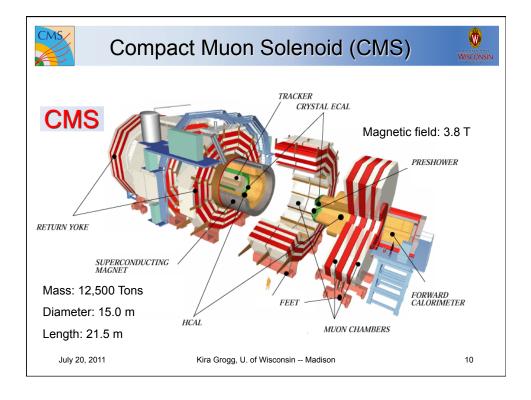


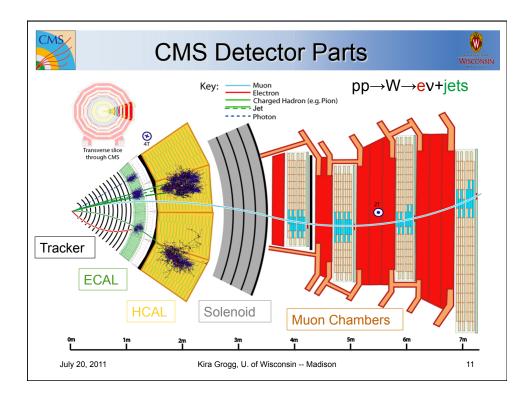


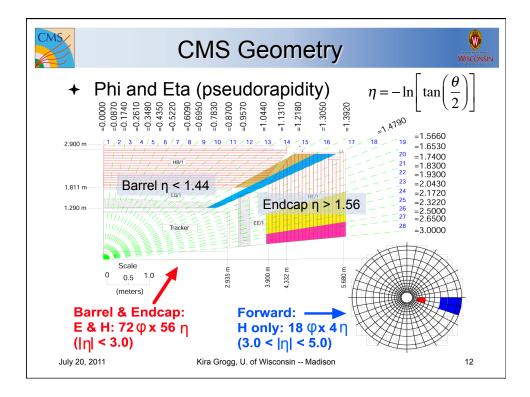


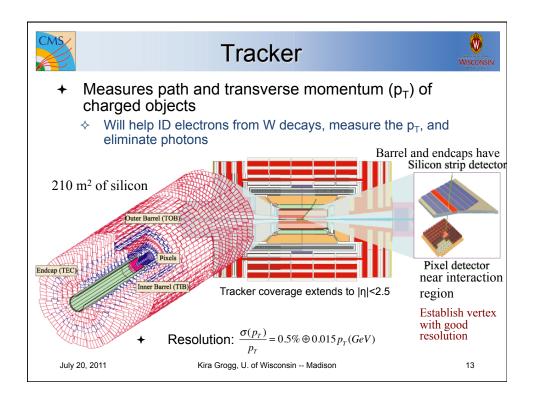


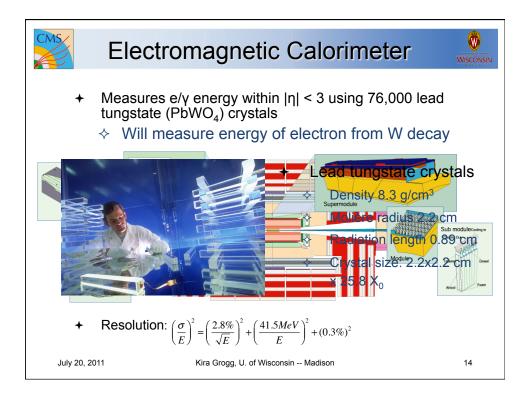


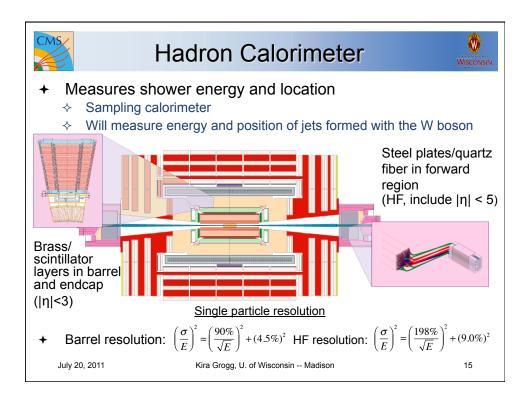




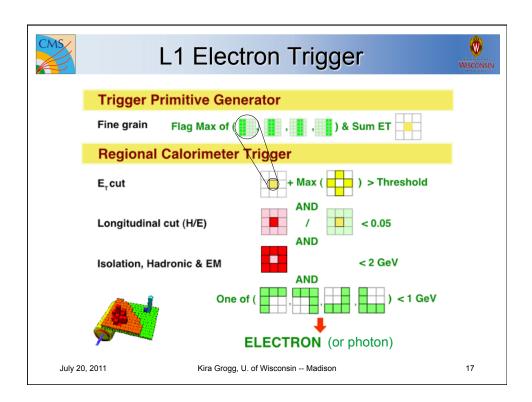


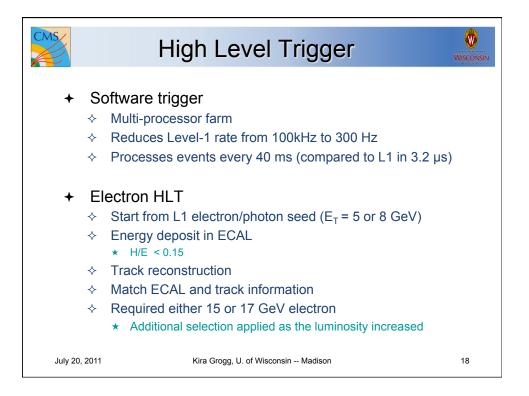


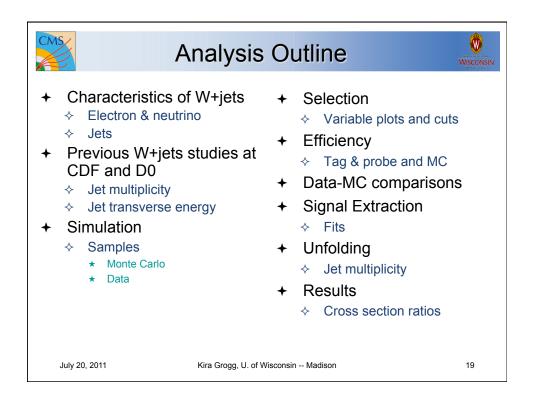


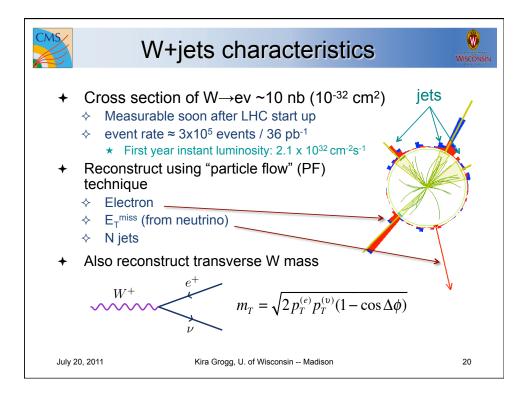


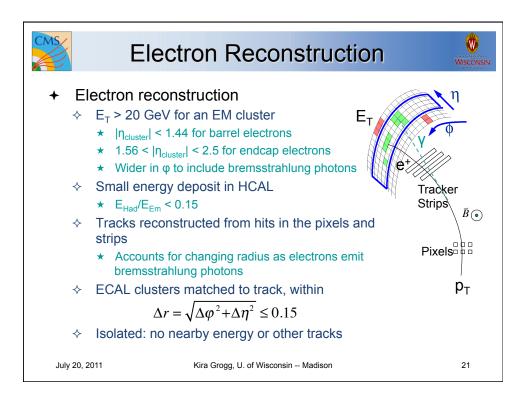
L	evel 1 Trigger	
 + 0.5 GHz frequency (~ 25 ns bunch crossings * 2.2 interactions), not all of the 0.2 MB events can be retained + L1 trigger electronics select 50-100 kHz of interesting events + Triggers > Electron/photon * 5 or 8 GeV * ~100% efficient > Jets > Missing E_T > Muon 	Calorimeter Trigger HF HCAL ECAL Regional Calorimeter Trigger Global Calorimeter Trigger Global Calorimeter Trigger Global Calorimeter Trigger Global Calorimeter Trigger CSC Trigger Global CSC Trigger CSC T	DT Local DT Trigger DT Track Finder
July 20, 2011	Kira Grogg, U. of Wisconsin Madison	16

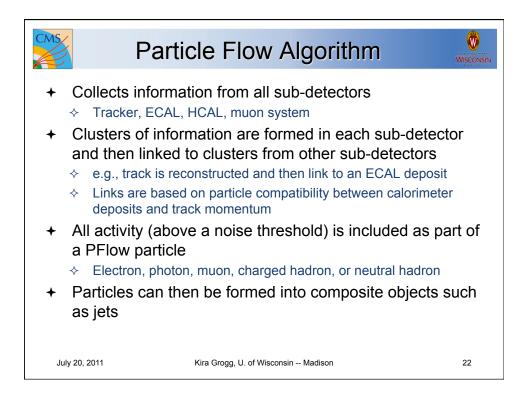


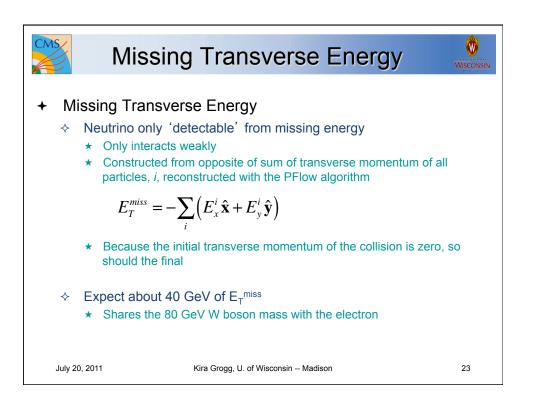


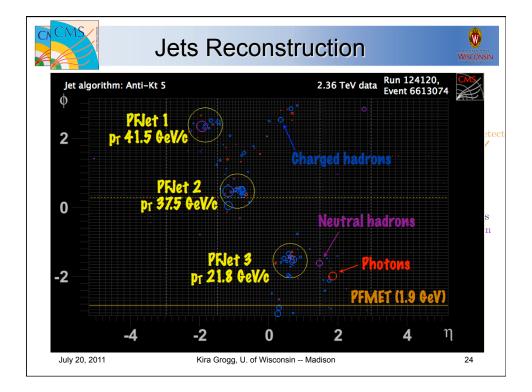


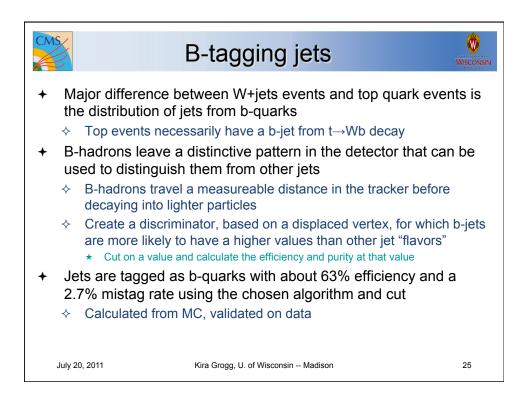




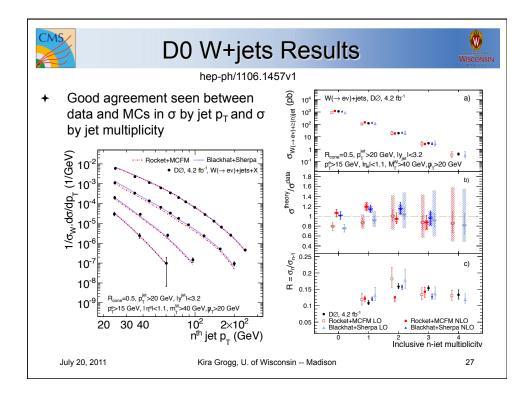


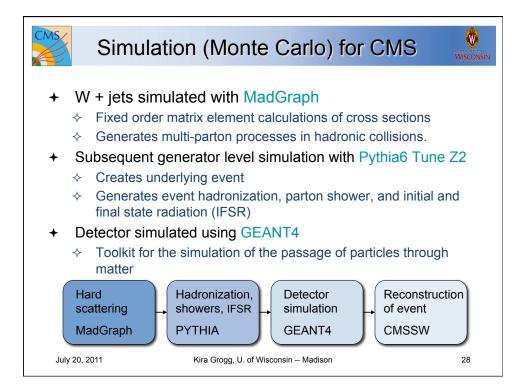




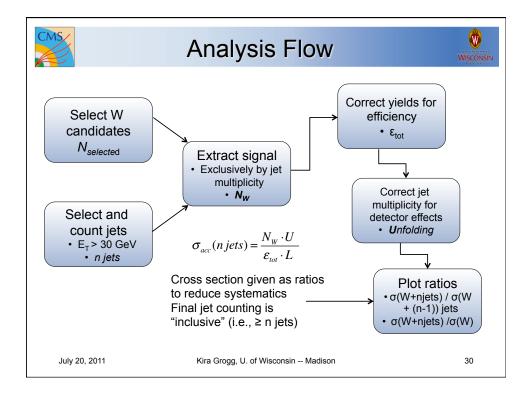


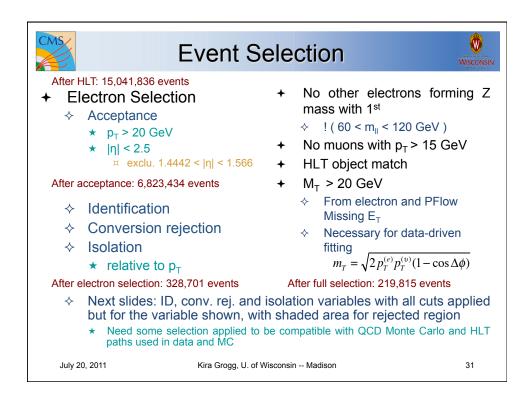
CMS	Tevatron (I	D0) W+jets
	Phys. Rev. D	77, 011108 (2008)
	Tevatron info: <pre></pre>	 ★ Measurement at D0 ★ L = 4.2 fb⁻¹ ♦ Select events with electron E_T > 15 GeV and η < 1.1; E_T^{miss} > 20 GeV; M_T > 40 GeV ♦ N jets, found using ♦ ΔR = 0.5 cone algorithm ♦ η < 3.2 ♦ E_T > 20 GeV for counting
July	20, 2011 Kira Grogg, U. of	Wisconsin Madison 26

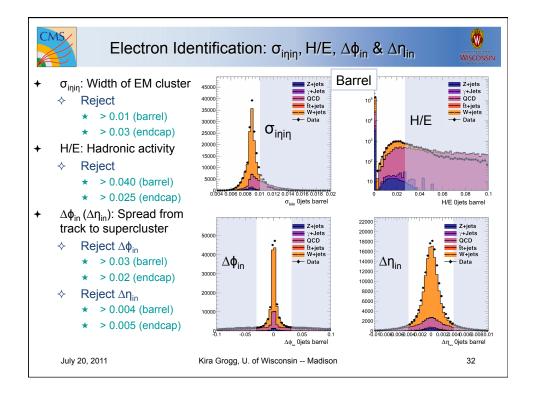


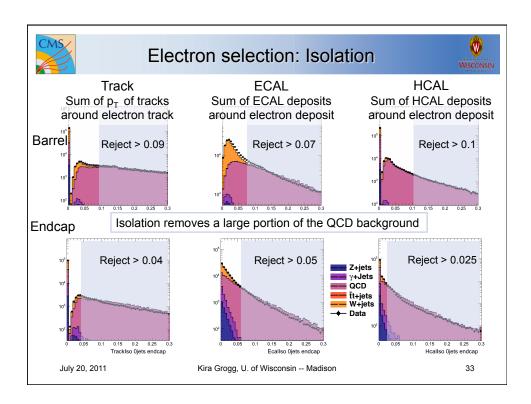


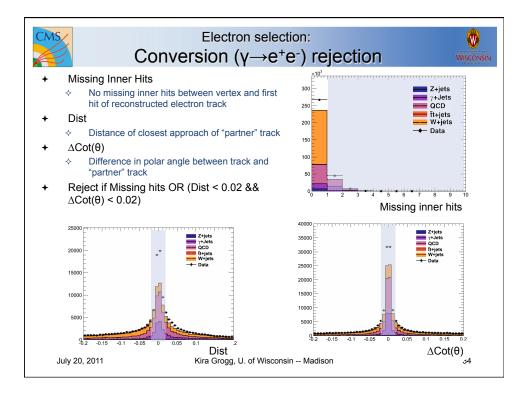
Data/Monte Carlo	(MC) Sample	es for CN	IS	
 → Data collected from June thr ◇ Only included declared "good" ◇ Total of 36.1 ± 1.4 pb⁻¹ 	•	010		
Run Range Trigger Name	Process	Generator	Cross se	c. (pb)
136033 - 137028 HLT_Photon10_L1R 138564 - 140401 HLT_Photon15_Cleaned_L1R	W+jets	MadGraph	31314	NNLO
141956 - 144114 HLT_Ele15_SW_CaloEleId_L1R 146428 - 147116 HLT_Ele17_SW_CaloEleId_L1R	Z+jets (M _{II} > 50 GeV)	MadGraph	3048	NNLO
147196 - 148058 HLT_Ele17_SW_TightEleId_L1R_v1 148822 - 149063 HLT_Ele17_SW_TighterEleIdIsol_L1R_v2	Ttbar	MadGraph	157	NLO
149181 - 149442 HLT_Ele17_SW_TighterEleIdIsol_L1R_v3	QCD (20 < p _T < 170 GeV)	Pythia	~10 ⁶	LO
 + MC samples listed in table ◇ Madgraph TuneZ2 is default 	Y+jet (15 < p _T < 80 GeV)	Pythia	~104-106	LO
 Pythia and Madgraph TuneD6T used for systematic studies 	NNLO cross sec Exclusive W and Monte Carlo for simulation code	d Z production FeMtobarn pr	" (FEWZ) O ocesses (M0	R CFM)
July 20, 2011 Kira Grogg,	U. of Wisconsin Madisor	1		29



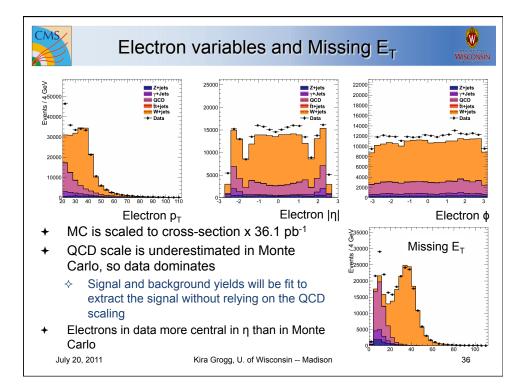


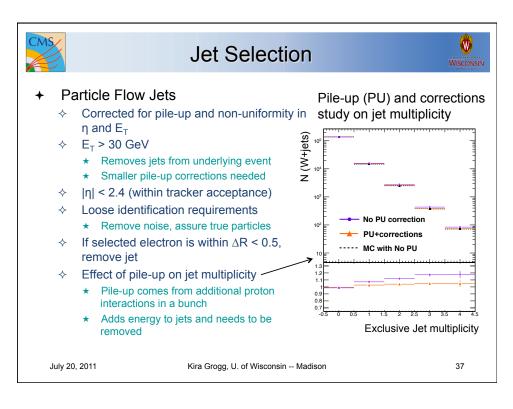




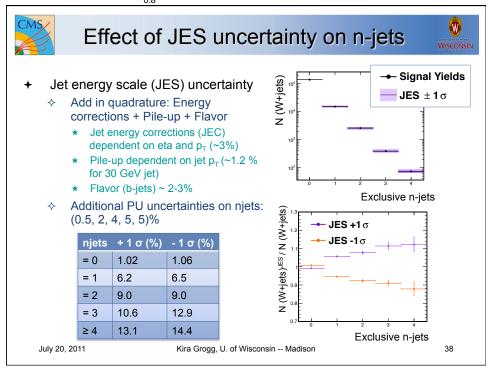


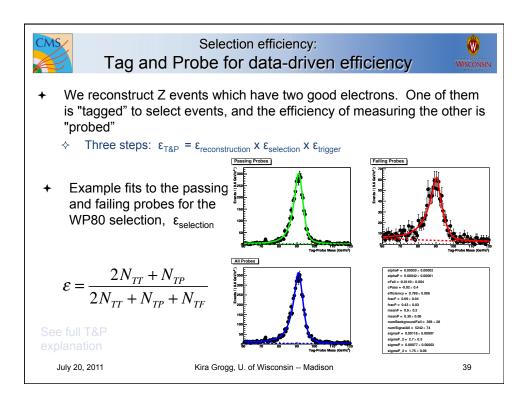
Electron Selection:	Summa	ary	Wiscon				
 Table at the right shows a 		Barrel	Endcap				
summary of the values used for	Identification	n					
the identification, conversion	$\sigma_{i\eta i\eta}$	0.01	0.03				
rejection, and isolation variables	$\Delta \phi_{in}$	0.03	0.02				
After acceptance: 6,823,434 events	$\Delta \eta_{in}$	0.004	0.005				
After ID Cuts: 1,205,840 events	H/E	0.04	0.025				
	Isolation						
	Track iso	0.09	0.04				
After locieties Outer 514 514 events	Ecal iso	0.07	0.05				
After Isolation Cuts: 514,511 events	Hcal iso	0.10	0.025				
	Conversion rejection						
	Missing hits	0	OR				
After conversion rejection: 328,701 events	Dist	(0.02 AND					
	∆cot(θ)	0.	.02)				
July 20, 2011 Kira Grogg, U. of Wisconsin	ly 20, 2011 Kira Grogg, U. of Wisconsin Madison 3						



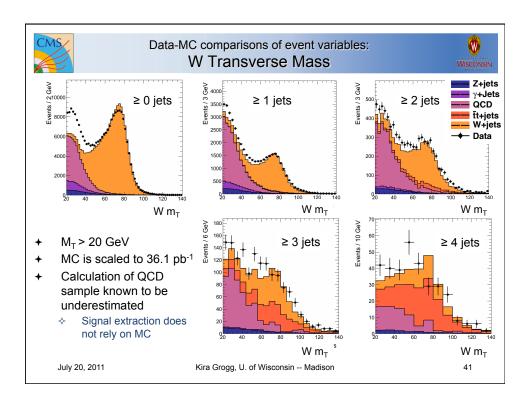


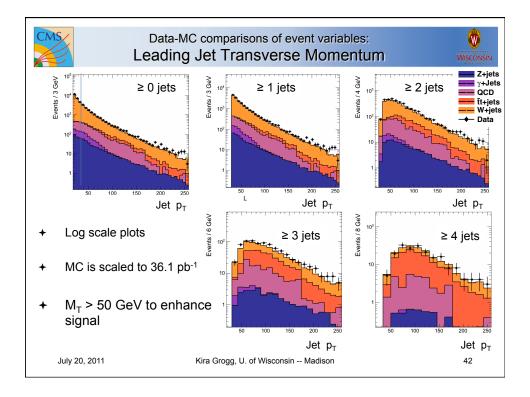


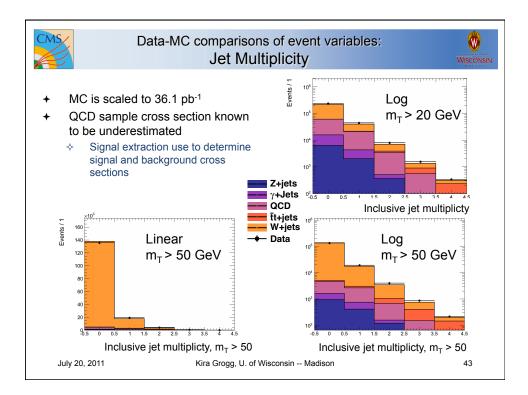




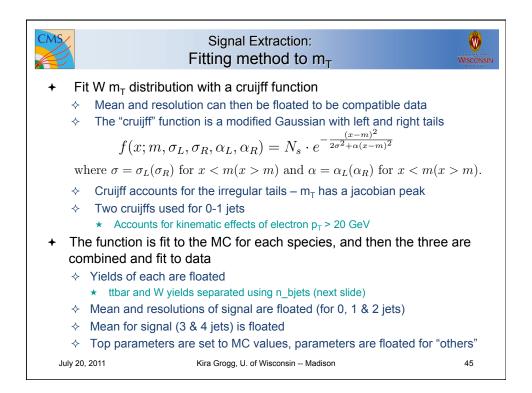
CMS	Selection Efficiency: Full Event Selection										
	 Measure efficiency using tag-and-probe strategy on Z+jets data and MC samples ◇ Electron selection efficiency found as a function of jet multiplicity ◇ Use jet E_T > 15 GeV to increase statistics Tag-and-probe results combined with the full W+jets MC selection for 										
	final selection efficience	y: full sele ator electro	on $p_{T} > 20 C$								
	Efficiency	0 jets	1 jets	2 jets	3 jets	≥ 4 jets					
	MC _w (full selection)	0.694	0.646	0.595	0.540	0.486					
	T&P data	0.752	0.743	0.722	0.735	0.693					
	T&P MC	0.732	0.733	0.729	0.720	0.710					
	ε _{Total} = MC * T&P data / T&P MC	0.713	0.655	0.589	0.551	0.474					
July	20, 2011 K	ira Grogg, U. c	f Wisconsin	Madison		40					

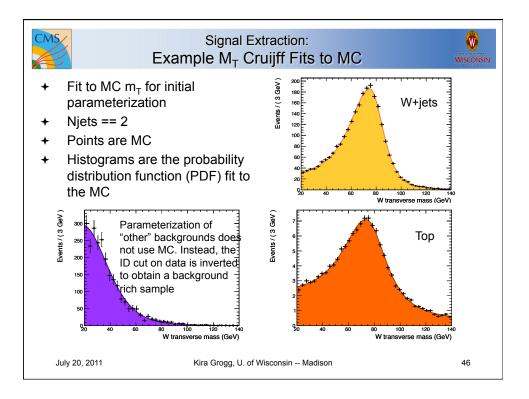


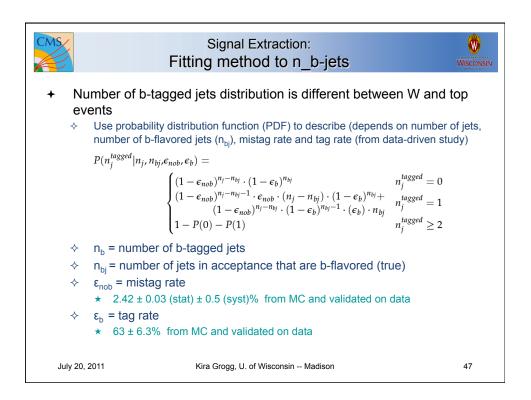


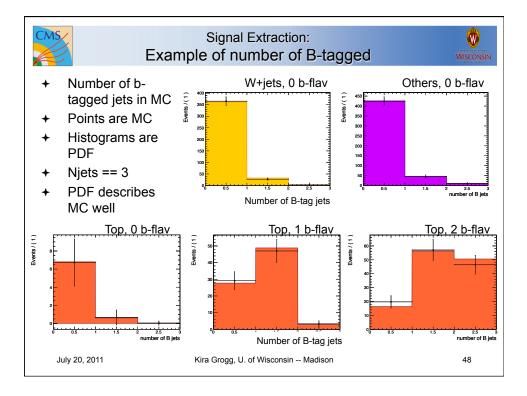


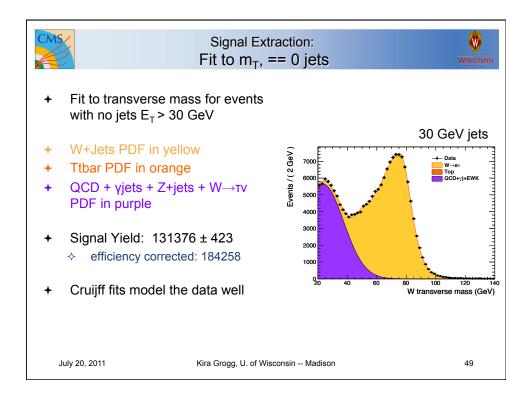
CMS	Signal Extraction: Strategy	
background ∻ Probabili	onal fits to W m _T to distinguish signal from majo ds ity distribution function (PDF) meterized on MC	ority of
♦ Top quai	umber of b-tagged jets to distinguish signal from rk decays to W, so it also peaks in M_T validated on data, no reliance on MC cross sections	·
 + Species: ⊹ Signal (V ◇ Top (ttba ★ Divide ◇ Others (D fits of $M_T \times n_{btagged}$ for each exclusive jet multip W+jets) ar, single top) ed into three subspecies based on number of b-jet (0, 1, ≥ (QCD, Z, W→TV, γjets) el based on a background enriched sample in data	
July 20, 2011	Kira Grogg, U. of Wisconsin Madison	44

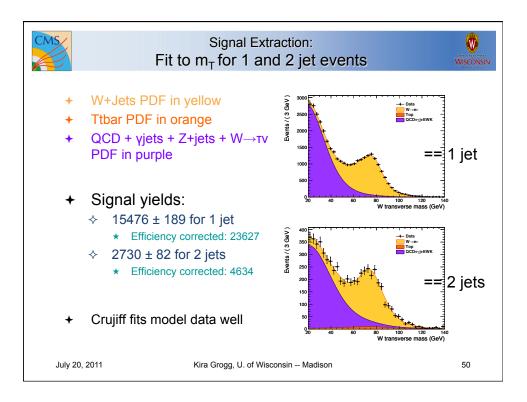


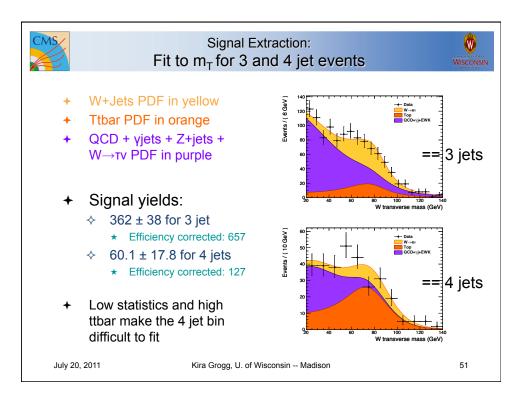


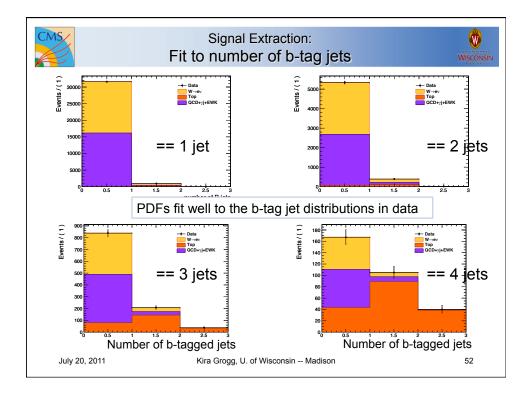


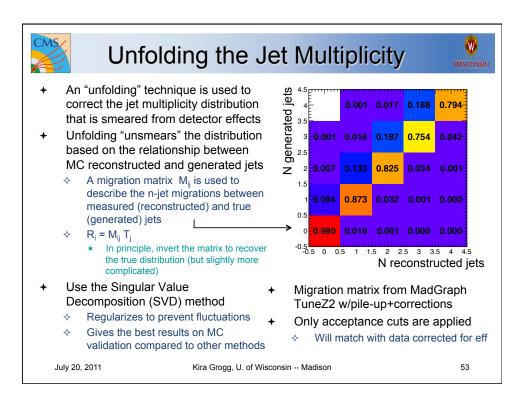


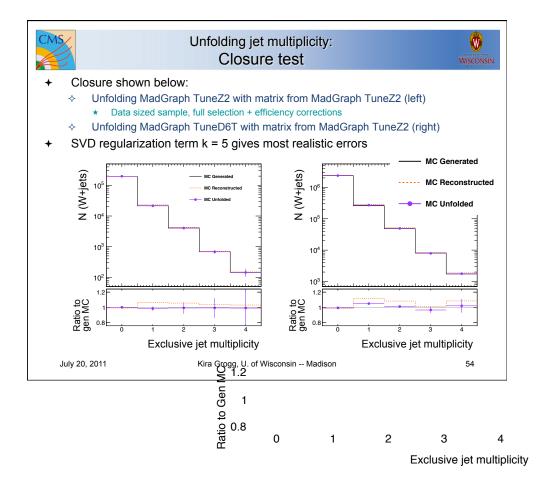


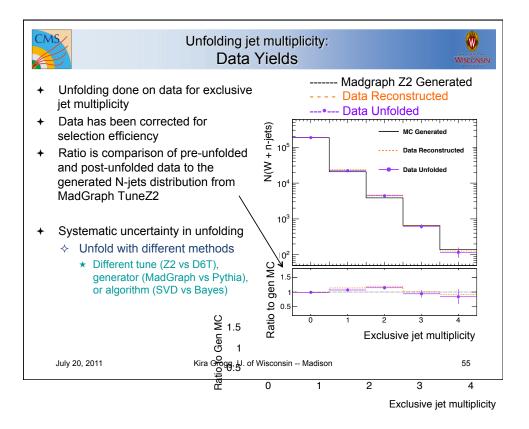




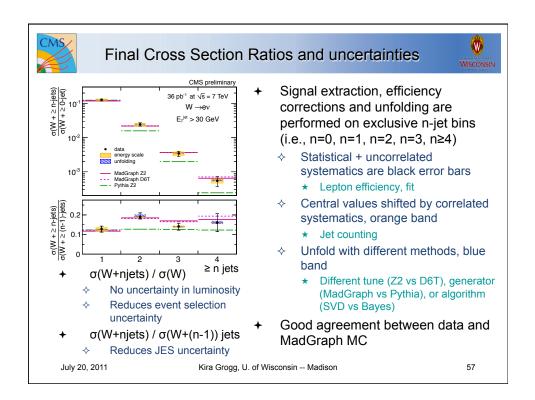


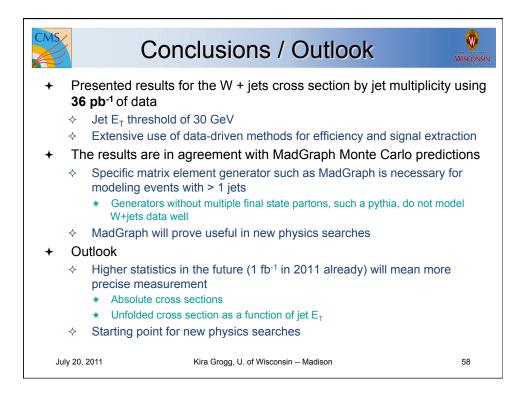


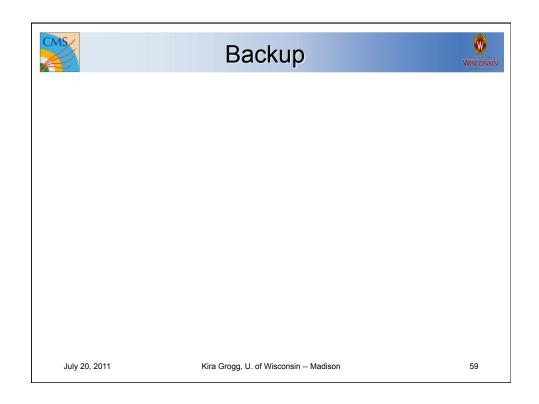


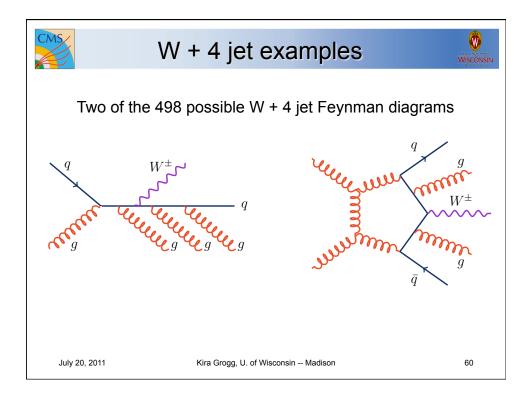


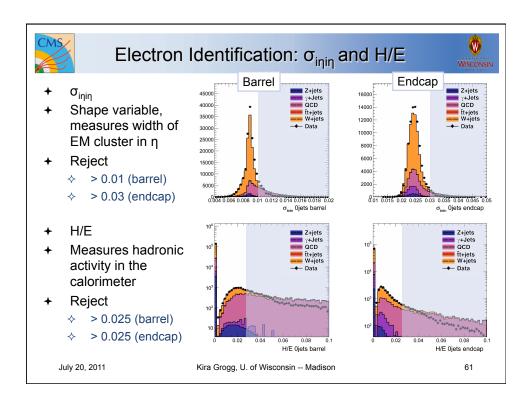
Sources of System	atic Unce	rtain	ty (%)	Ŵ	
 + Jet energy scale ♦ Jet energy corrections 	Njets	0	1	2	3	4
 dependent on η and p_T (~3%) Pile-up (~1.2 % for 30 GeV jet) 	JES +1σ JES -1σ	1.02 1.06	6.2 6.5	9.0 9.0	10.6 12.9	4 13.1 14.4
★ Flavor set to 2-3%	$\text{Missing } E_{T}$	0.1	0.3	0.5	0.5	1.4
	Efficiency Fit	0.5 0.1	0.3 0.8	0.8 1.26	1.4 4.16	2.7 8.95
+ Efficiency	Total + -		6.27 6.56	9.14 9.14	11.5 13.6	16.2 17.2
 ♦ From Tag and Probe and MC counting ♦ Fit ♦ B-tag variables uncertainties ♦ QCD modeling ♦ Fixed parameters in m_T fit 	by me	unfold ethods minal Not ir	and concluded	rtainty th differ ompari in table nal resu	rent ng to th above	ne
July 20, 2011 Kira Grogg, U. of	f Wisconsin Madi	son				56

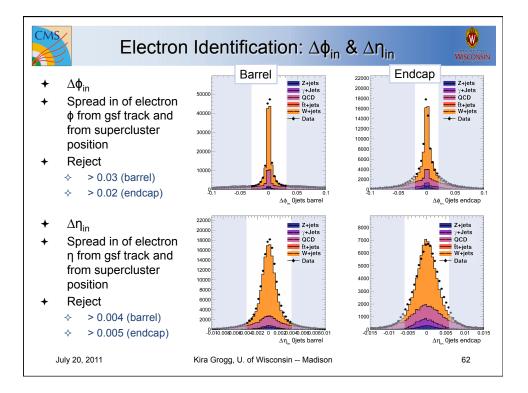


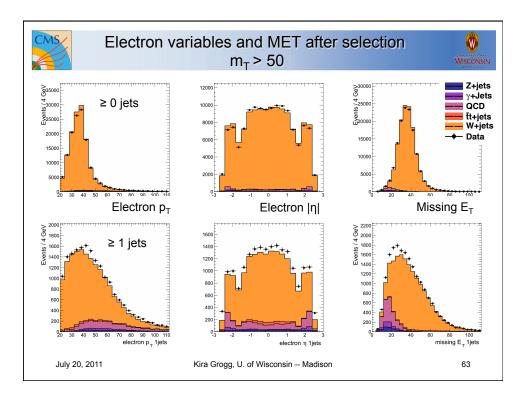


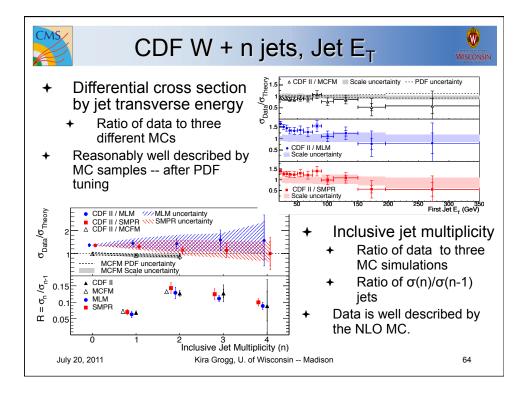


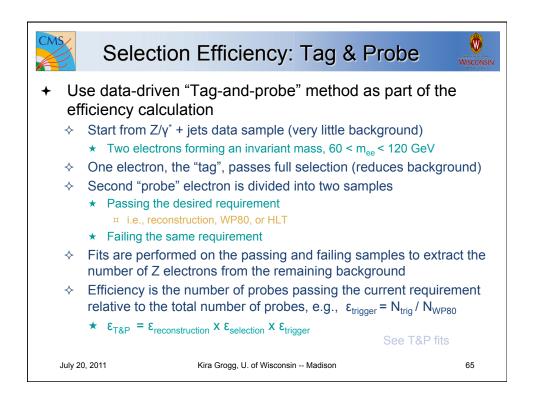


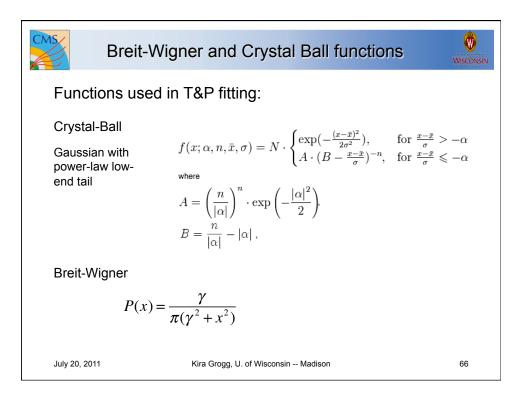


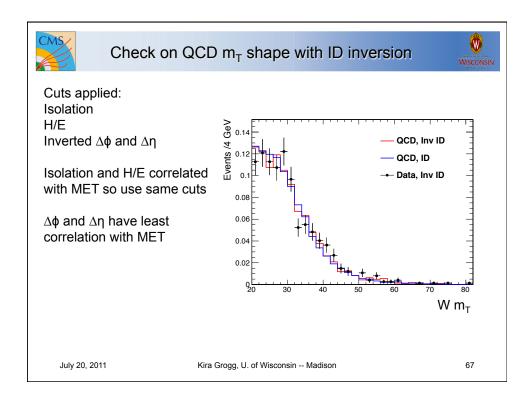


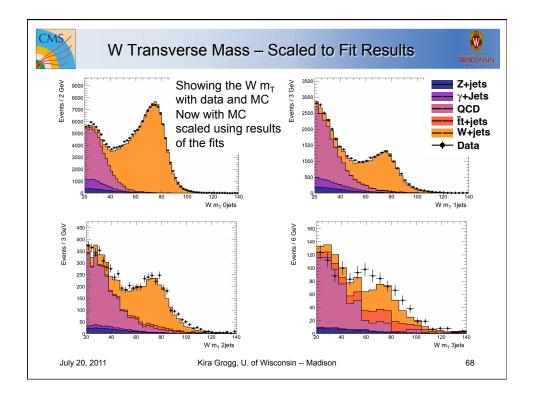


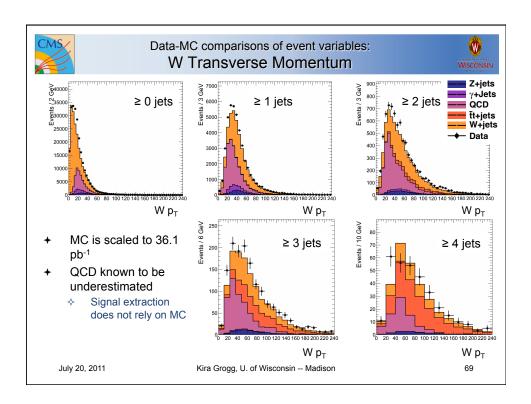


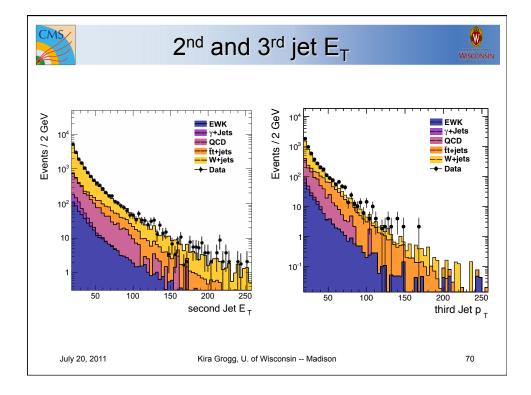


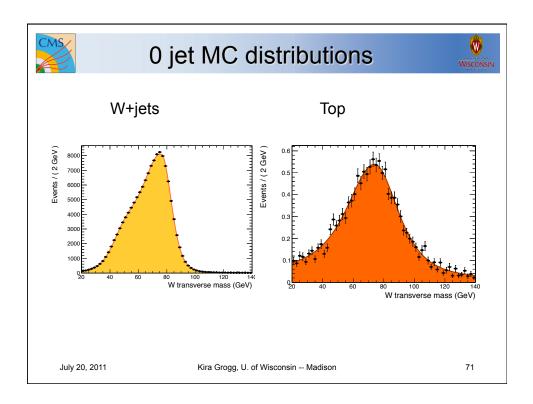


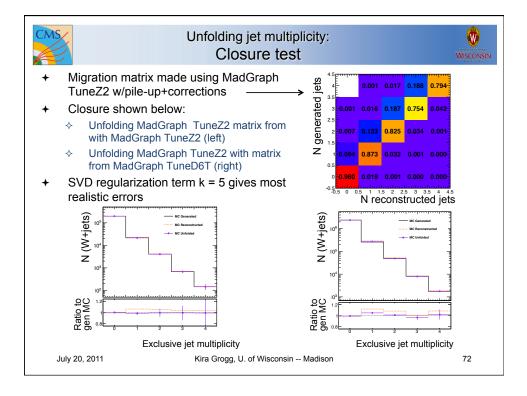












Results: N events for = n jets									
	-								
			PF jet p_T	> 30 GeV					
					Unfolding	systematic dev	iation		
n jets	$N_{\rm obs}$	$\epsilon_{\rm tot}$	N_{effcor}	$N_{\rm unf}$	SVD - Bayes	MC generator	MC tune		
0	131376 ± 423	0.713 ± 0.0049	184258 ± 1399	185946 ± 1525	4.0	697.0	-26.0		
1	15476 ± 189	0.655 ± 0.00624	23627 ± 366	22198 ± 473	-7.2	-926.8	-84.9		
2	2730 ± 81.6	0.589 ± 0.0115	4635 ± 165	4433 ± 217	7.6	208.1	90.4		
3	362 ± 38.1	0.551 ± 0.0269	657 ± 76	613 ± 81	-6.2	14.7	9.1		
4	60 ± 17.8	0.474 ± 0.0421	127 ± 39	117 ± 35	0.4	-2.3	10.1		
				_					
able	8.1: Nobe 6	are the result:	s from the si	ignal extract	ion, N _{effcor}	are the rest	ults aft		

Table 8.1: $N_{\rm obs}$ are the results from the signal extraction, $N_{\rm effcor}$ are the results after correcting for electron efficiency, $\epsilon_{\rm tot}$, and $N_{\rm unf}$ are the results after unfolding, all with with exclusive jet counting. The last three columns represent the deviation from the nominal unfolding results when changing the algorithm, the MC generator, and the MC tune, respectively.

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MS		R	esults		`\ \/ +>	niete)		0
2			Counts	5. 0(VVIE	ijets)		WISCON
			PI	F jet p_T	$- > 30 \text{ Ge}^{-1}$	V		
n jets	σ	stat	stat+sys	JES s	yst error	Unfolding	g systematic devi	iation
	in acceptance				(\pm)	SVD - Bayes	MC generator	MC tune
≥ 0 jets	5909	33.4	44.7	2.50	2.92	-0.04	-0.26	-0.04
≥ 1 jets	758	12.8	14.6	60.0	62.7	-0.15	-19.6	0.68
	1 49	F 00	6.49	14.2	14.6	0.05	6.11	3.04
≥ 2 jets	143	5.92	0.49	14.2	14.0	0.00	0.11	0.01
≥ 2 jets ≥ 3 jets	143 20.2	$\frac{5.92}{2.30}$	0.49 2.44	14.2 2.36	2.88	-0.16	0.34	0.53

Table 8.2: Results for cross section $\sigma (\geq n \text{ jets})$ within the acceptance with inclusive jet counting. Sources of uncertainty shown are statistical, statistical + uncorrelated systematics (fit and efficiency), correlated systematics (jet energy scale, JES), and deviations when using different unfolding methods (algorithm, generator, and tune). There is also an overall 4% uncertainty for the luminosity.

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		esun	3. 0(v v · <u>~</u> 1	ijet <i>s ji</i>	/σ(W)		WISCONS
				et $p_T > 30$		** 0.1.1.		
n jets	σ ratio	stat	stat+sys		st error		g systematic devi	
> 1 / > 0 * *	in acceptance	0.000	0.0000.1	(=		SVD - Bayes	MC generator	MC tune
$\geq 1 / \geq 0$ jets	0.128	0.002	0.00234	0.0101	0.0106	-2.47e-05	-0.00331	0.000117
$\geq 2 / \geq 0$ jets	0.0242	0.000987	0.00109	0.00239	0.00246	8.33e-06	0.00103	0.000514
$\geq 3 / \geq 0$ jets $\geq 4 / \geq 0$ jets	0.00342 0.000547	0.000388	0.000413 0.000164	0.000397 7.35e-05	0.000486 8.63e-05	-2.75e-05 1.73e-06	5.83e-05 -1.08e-05	9.02e-05 4.75e-05
ith inclusiv ncorrelated	ve jet count l systematic	ing. Sou cs (fit an	urces of nd efficie	uncerta ency), co	inty sho orrelated	wn are stat l systemati	ithin the ac tistical, stat ics (jet ener lgorithm, g	istical gy scal
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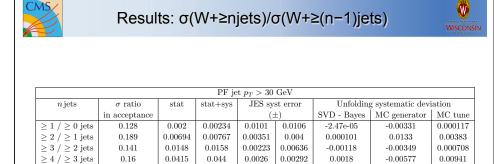


Table 8.4: Results for cross section ratio $\sigma(W + \ge n \text{ jets})/\sigma(W + \ge (n-1) \text{ jets})$ within the acceptance with inclusive jet counting. Sources of uncertainty shown are statistical, statistical + uncorrelated systematics (fit and efficiency), correlated systematics (jet energy scale, JES), and deviations when using different unfolding methods (algorithm, generator, and tune).

